Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/541,034	SHIMAWAKI ET AL.
Examiner	Art Unit
Shih-Chao Chen	2821

	SEARCHED				
Class	Subclass	Date	Examiner		
343	705, 756, 781CA, 781P, 786	3/1/2006	CHEN		
			:		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
343	705,756	3/1/2006	CHEN	
343	781CA	3/1/2006	CHEN	

SEARCH NO (INCLUDING SEARC		·)
	DATE	EXMR
EAST(See attached printout).	3/1/2006	CHEN